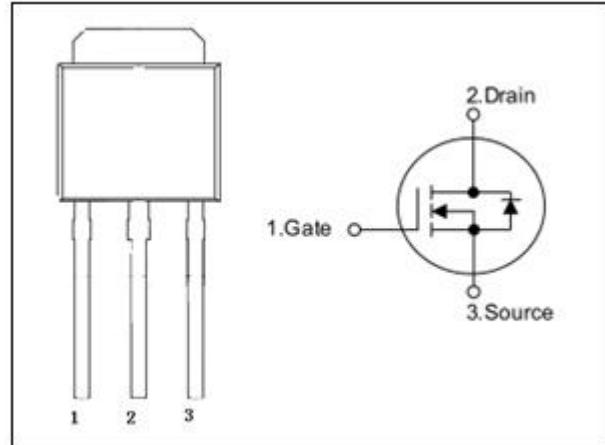


Isc N-Channel MOSFET Transistor
MMIS70R900PTH
• FEATURES

- With TO-251(IPAK) packaging
- Low power loss
- High speed switching
- Low on-resistance
- 100% avalanche tested
- Minimum Lot-to-Lot variations for robust device performance and reliable operation

• APPLICATIONS

- Switching applications
- DC - DC Converters


• ABSOLUTE MAXIMUM RATINGS($T_a=25^\circ\text{C}$)

SYMBOL	PARAMETER	VALUE	UNIT
V_{DSS}	Drain-Source Voltage	700	V
V_{GSS}	Gate-Source Voltage	± 30	V
I_D	Drain Current-Continuous@ $T_c=25^\circ\text{C}$ $T_c=100^\circ\text{C}$	5 3	A
I_{DM}	Drain Current-Single Pulsed	15	A
P_D	Total Dissipation	40	W
T_{ch}	Max. Operating Junction Temperature	150	$^\circ\text{C}$
T_{stg}	Storage Temperature	-55~150	$^\circ\text{C}$

• THERMAL CHARACTERISTICS

SYMBOL	PARAMETER	MAX	UNIT
$R_{th(ch-c)}$	Channel-to-case thermal resistance	3.1	$^\circ\text{C}/\text{W}$
$R_{th(ch-a)}$	Channel-to-ambient thermal resistance	62.5	$^\circ\text{C}/\text{W}$

Isc N-Channel MOSFET Transistor
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ELECTRICAL CHARACTERISTICS

T_c=25°C unless otherwise specified

SYMBOL	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNIT
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V; I _D = 0.25mA	700			V
V _{GS(th)}	Gate Threshold Voltage	V _{DS} = ±30V; I _D =0.25mA	2		4	V
R _{DS(on)}	Drain-Source On-Resistance	V _{GS} = 10V; I _D =1.5A		810	900	mΩ
I _{GSS}	Gate-Source Leakage Current	V _{GS} = ±30V; V _{DS} = 0V			±0.1	μA
I _{DSS}	Drain-Source Leakage Current	V _{DS} =700V; V _{GS} = 0V;			1	μA
V _{SDF}	Diode forward voltage	I _{SD} =5A, V _{GS} = 0 V			1.4	V

TO-251 OUTLINE DIMENSIONAL DRAWING
